Search Notes						

Application/Control No.	Applicant(s)/Patent un Reexamination	Applicant(s)/Patent under Reexamination	
10/555,646	VASILESCU ET AL.		
Examiner	Art Unit		
Nguyen N. Hanh	2834		

SEARCHED				
Subclass	Date	Examiner		
52	4/4/2007	ни		
54	4/4/2007	HN		
58	4/4/2007	HN		
64	4/4/2007	H		
62	12/14/07	HN		
AH	12 15/07	HIN		
	52 54 58 64 62	Subclass Date 52 4/4/2007 54 4/4/2007 58 4/4/2007 64 4/4/2007 62 1/2/14/07		

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
62	12/15/07	HA1		
	Subclass	Subclass Date		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PG Pub Text search, se interference search print out	12/15/07	HN		
	•	,		
	·			